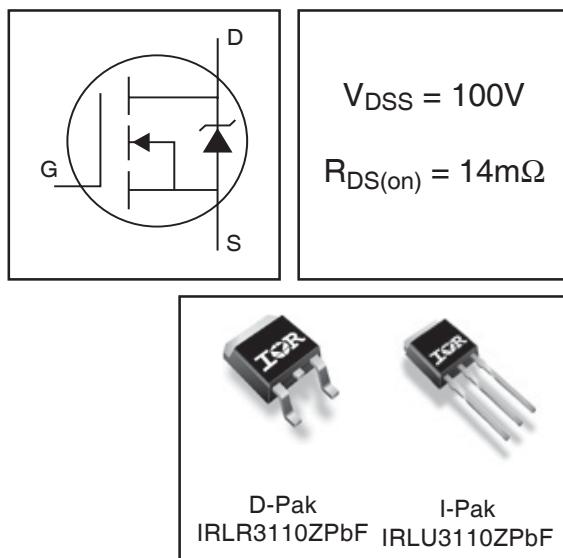


### Features

- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to  $T_{jmax}$

### Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.



### Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ (Silicon Limited)	63	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ (Silicon Limited)	45	
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ (Package Limited)	42	
$I_{DM}$	Pulsed Drain Current ①	250	
$P_D @ T_C = 25^\circ C$	Power Dissipation	140	W
	Linear Derating Factor	0.95	W/ $^\circ C$
$V_{GS}$	Gate-to-Source Voltage	$\pm 16$	V
$E_{AS}$ (Thermally limited)	Single Pulse Avalanche Energy ②	110	mJ
$E_{AS}$ (Tested )	Single Pulse Avalanche Energy Tested Value ⑥	140	
$I_{AR}$	Avalanche Current ①	See Fig.12a, 12b, 15, 16	A
$E_{AR}$	Repetitive Avalanche Energy ⑤		mJ
$T_J$	Operating Junction and	-55 to + 175	$^\circ C$
$T_{STG}$	Storage Temperature Range		
	Reflow Soldering Temperature, for 10 seconds		
	Mounting Torque, 6-32 or M3 screw	300	
		10 lbf•in (1.1N•m)	

### Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{0JC}$	Junction-to-Case ⑧	—	1.05	$^\circ C/W$
$R_{0JA}$	Junction-to-Ambient (PCB mount) ⑦ ⑧	—	40	
$R_{0JA}$	Junction-to-Ambient ⑧	—	110	

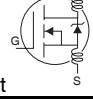
HEXFET® is a registered trademark of International Rectifier.

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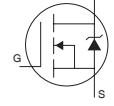
# IRLR/U3110ZPbF

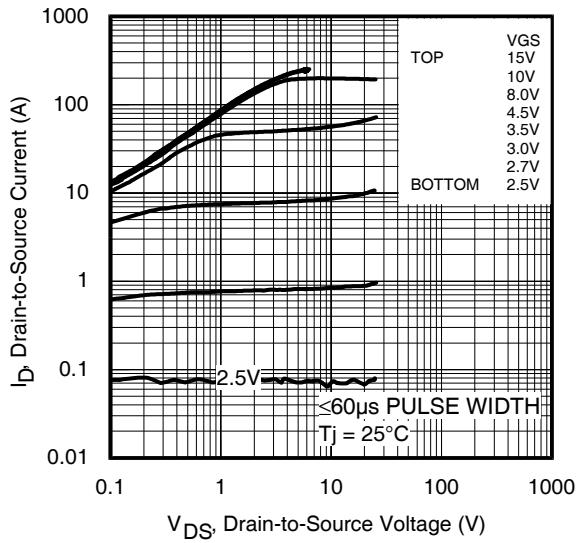
International  
Rectifier

## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

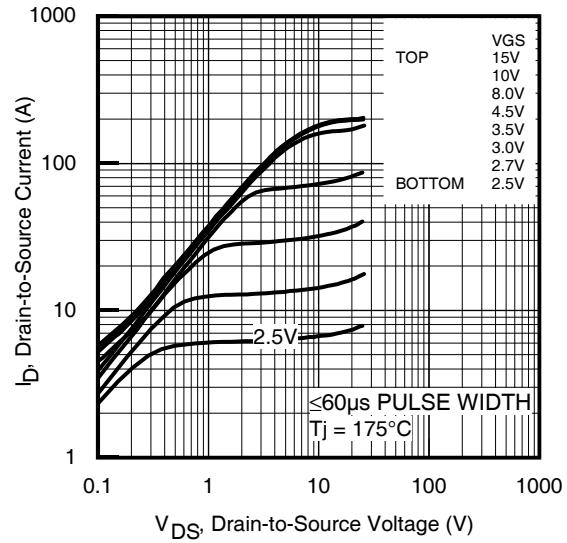
	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	100	—	—	V	$V_{GS} = 0V, I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.077	—	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}, I_D = 1\text{mA}$
$R_{DS(\text{on})}$	Static Drain-to-Source On-Resistance	—	11	14	$\text{m}\Omega$	$V_{GS} = 10V, I_D = 38\text{A}$ ③
		—	12	16		$V_{GS} = 4.5V, I_D = 32\text{A}$ ③
$V_{GS(\text{th})}$	Gate Threshold Voltage	1.0	—	2.5	V	$V_{DS} = V_{GS}, I_D = 100\mu\text{A}$
$g_{fs}$	Forward Transconductance	52	—	—	S	$V_{DS} = 25V, I_D = 38\text{A}$
$I_{DSS}$	Drain-to-Source Leakage Current	—	—	20	$\mu\text{A}$	$V_{DS} = 100V, V_{GS} = 0V$
		—	—	250		$V_{DS} = 100V, V_{GS} = 0V, T_J = 125^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Forward Leakage	—	—	200	nA	$V_{GS} = 16V$
	Gate-to-Source Reverse Leakage	—	—	-200		$V_{GS} = -16V$
$Q_g$	Total Gate Charge	—	34	48	nC	$I_D = 38\text{A}$
$Q_{gs}$	Gate-to-Source Charge	—	10	—		$V_{DS} = 50V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	—	15	—		$V_{GS} = 4.5V$ ③
$t_{d(on)}$	Turn-On Delay Time	—	24	—	ns	$V_{DD} = 50V$
$t_r$	Rise Time	—	110	—		$I_D = 38\text{A}$
$t_{d(off)}$	Turn-Off Delay Time	—	33	—		$R_G = 3.7\Omega$
$t_f$	Fall Time	—	48	—		$V_{GS} = 4.5V$ ③
$L_D$	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6mm (0.25in.) from package and center of die contact
$L_S$	Internal Source Inductance	—	7.5	—		
$C_{iss}$	Input Capacitance	—	3980	—	pF	$V_{GS} = 0V$
$C_{oss}$	Output Capacitance	—	310	—		$V_{DS} = 25V$
$C_{rss}$	Reverse Transfer Capacitance	—	130	—		$f = 1.0\text{MHz}$
$C_{oss}$	Output Capacitance	—	1820	—		$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0\text{MHz}$
$C_{oss}$	Output Capacitance	—	170	—		$V_{GS} = 0V, V_{DS} = 80V, f = 1.0\text{MHz}$
$C_{oss \text{ eff.}}$	Effective Output Capacitance	—	320	—		$V_{GS} = 0V, V_{DS} = 0V \text{ to } 80V$ ④

## Source-Drain Ratings and Characteristics

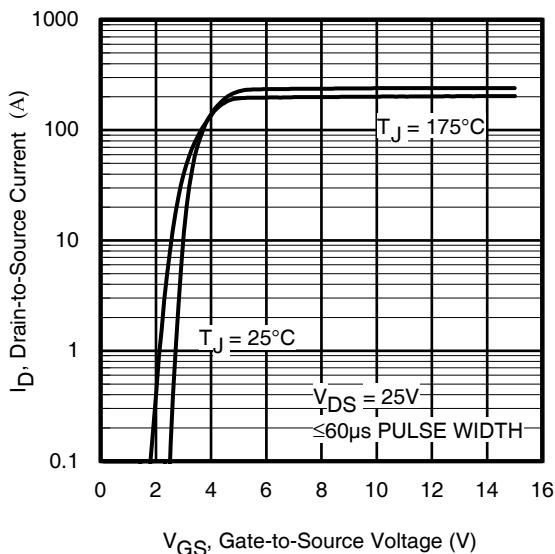
	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	63	A	MOSFET symbol showing the integral reverse p-n junction diode.
	Pulsed Source Current (Body Diode) ①	—	—	250		
$V_{SD}$	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}, I_S = 38\text{A}, V_{GS} = 0V$ ③
$t_{rr}$	Reverse Recovery Time	—	34	51	ns	$T_J = 25^\circ\text{C}, I_F = 38\text{A}, V_{DD} = 50V$
$Q_{rr}$	Reverse Recovery Charge	—	42	63	nC	$dI/dt = 100\text{A}/\mu\text{s}$ ③
$t_{on}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				



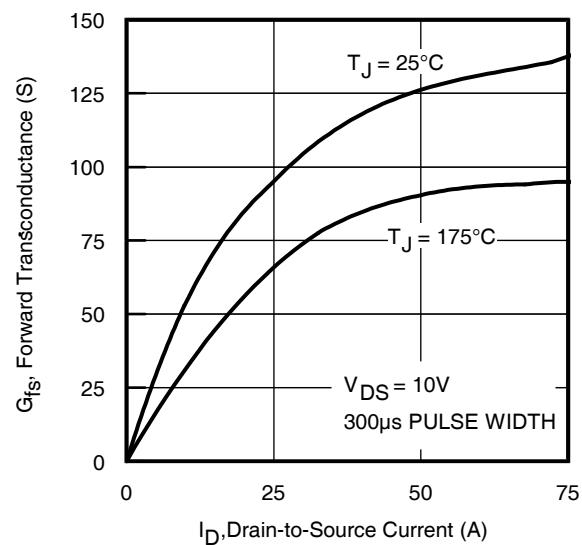
**Fig 1.** Typical Output Characteristics



**Fig 2.** Typical Output Characteristics



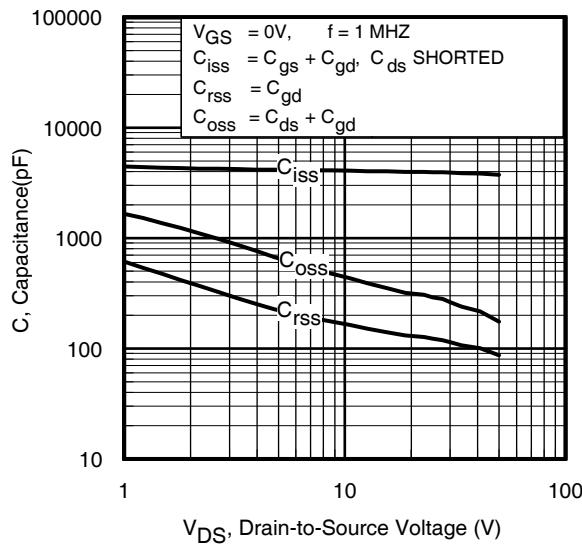
**Fig 3.** Typical Transfer Characteristics



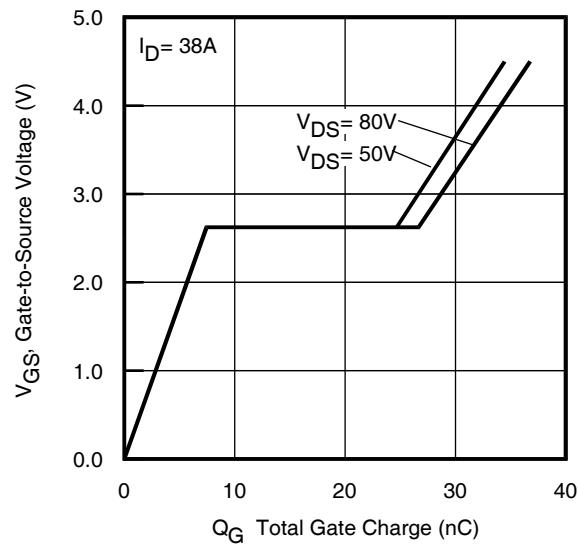
**Fig 4.** Typical Forward Transconductance  
vs. Drain Current

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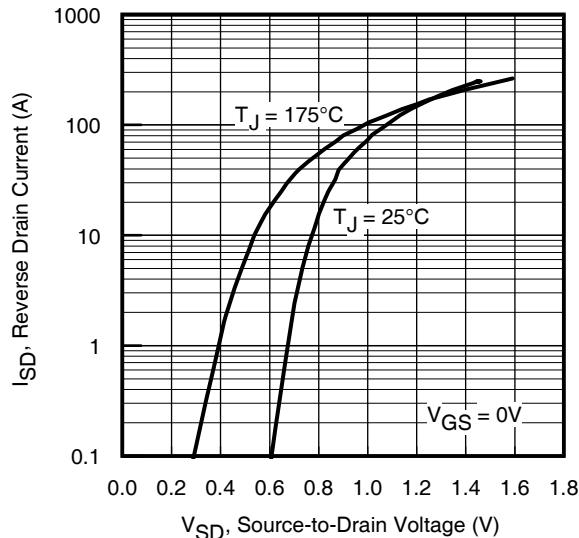
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**IR** Rectifier



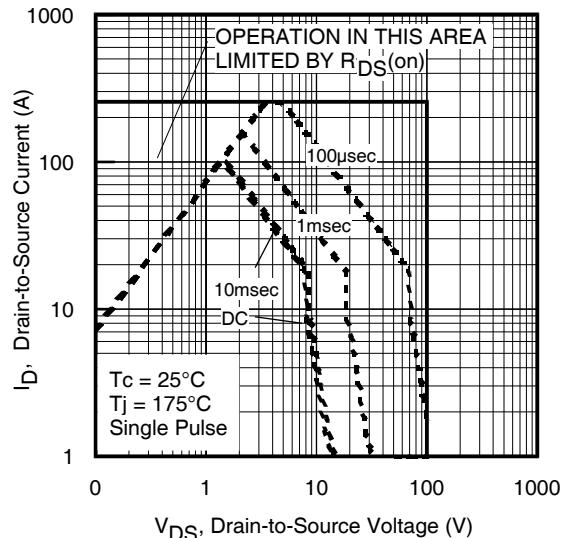
**Fig 5.** Typical Capacitance vs.  
Drain-to-Source Voltage



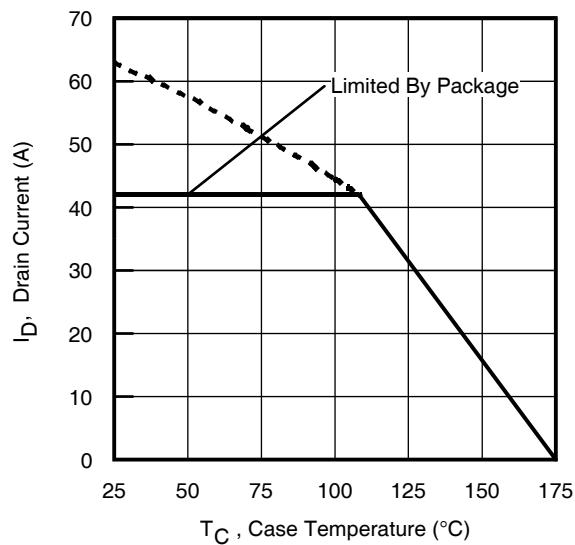
**Fig 6.** Typical Gate Charge vs.  
Gate-to-Source Voltage



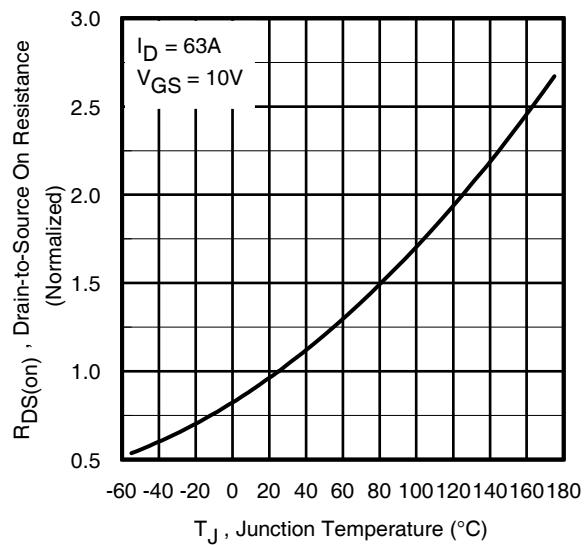
**Fig 7.** Typical Source-Drain Diode  
Forward Voltage



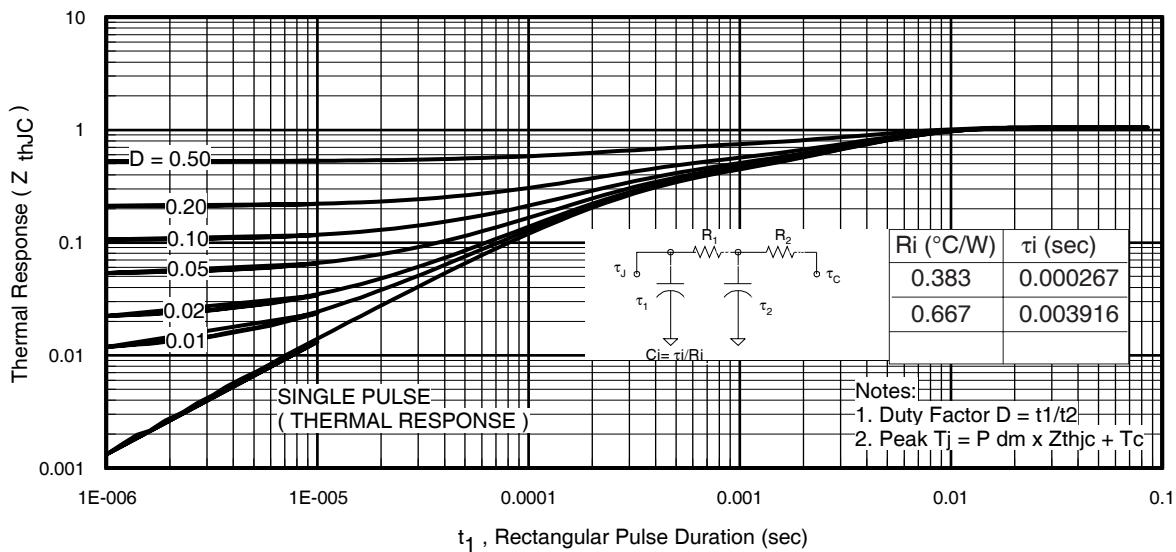
**Fig 8.** Maximum Safe Operating Area



**Fig 9.** Maximum Drain Current vs.  
Case Temperature



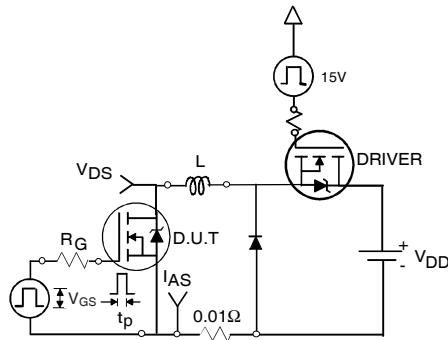
**Fig 10.** Normalized On-Resistance  
vs. Temperature



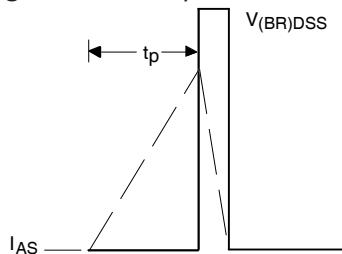
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

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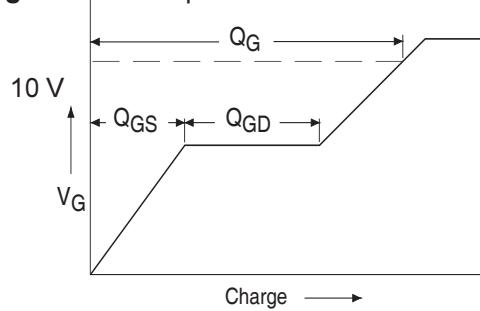
International  
**IR** Rectifier



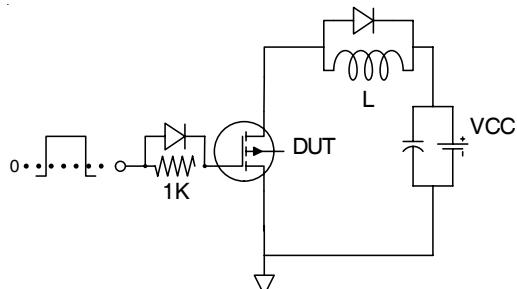
**Fig 12a.** Unclamped Inductive Test Circuit



**Fig 12b.** Unclamped Inductive Waveforms

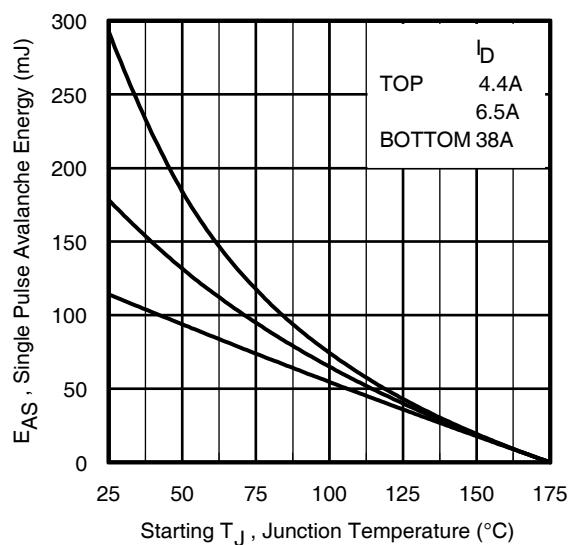


**Fig 13a.** Basic Gate Charge Waveform

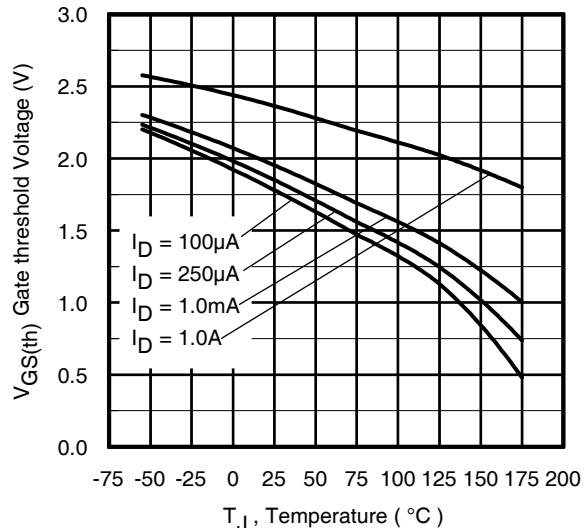


**Fig 13b.** Gate Charge Test Circuit

6

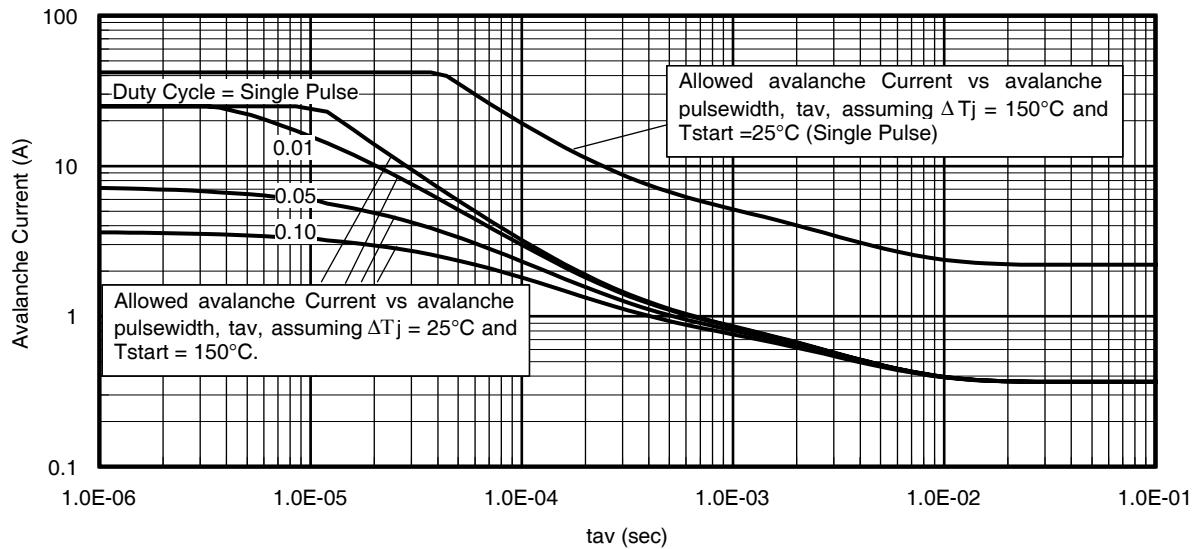


**Fig 12c.** Maximum Avalanche Energy vs. Drain Current

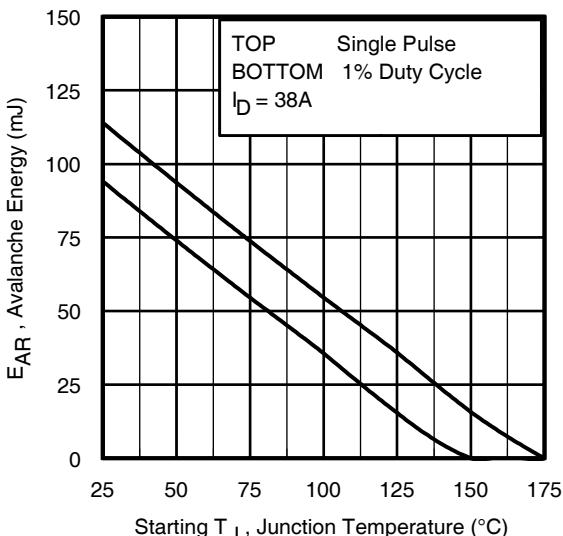


**Fig 14.** Threshold Voltage vs. Temperature

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**Fig 15.** Typical Avalanche Current vs.Pulsewidth



**Fig 16.** Maximum Avalanche Energy vs. Temperature

[www.irf.com](http://www.irf.com)

**Notes on Repetitive Avalanche Curves , Figures 15, 16:  
 (For further info, see AN-1005 at [www.irf.com](http://www.irf.com))**

1. Avalanche failures assumption:  
 Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
  2. Safe operation in Avalanche is allowed as long as neither  $T_{jmax}$  nor  $I_{av}$  (max) is exceeded.
  3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
  4.  $P_D(\text{ave})$  = Average power dissipation per single avalanche pulse.
  5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
  6.  $I_{av}$  = Allowable avalanche current.
  7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as  $25^\circ\text{C}$  in Figure 15, 16).
- $t_{av}$  = Average time in avalanche.  
 $D$  = Duty cycle in avalanche =  $t_{av} \cdot f$   
 $Z_{thJC}(D, t_{av})$  = Transient thermal resistance, see figure 11)

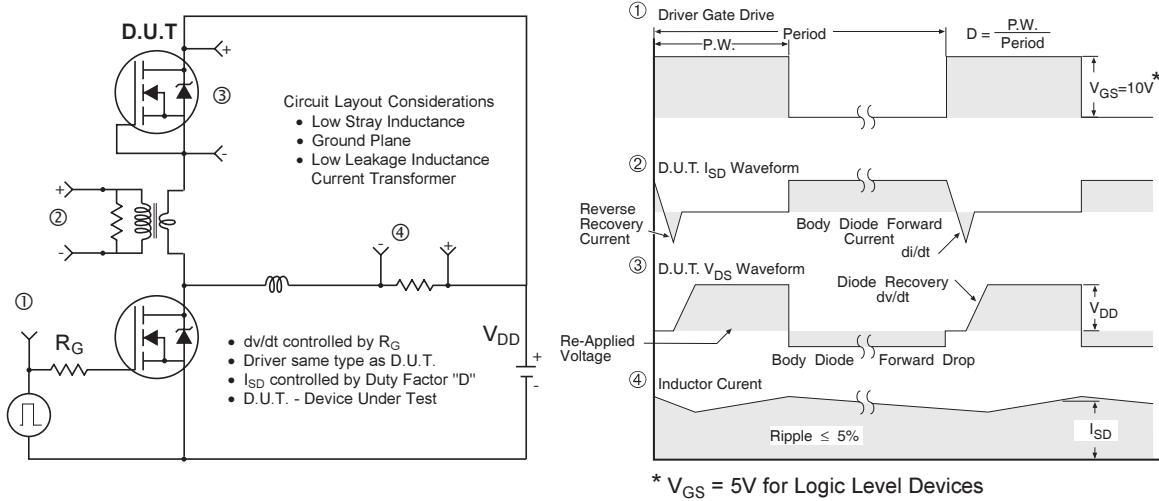
$$P_D(\text{ave}) = 1/2 (1.3 \cdot BV \cdot I_{av}) = \Delta T / Z_{thJC}$$

$$I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$$

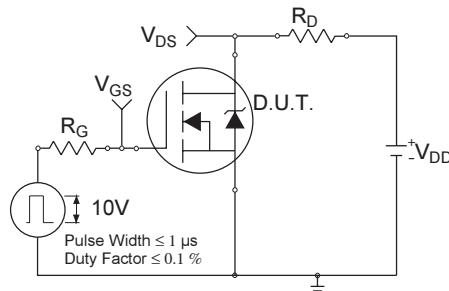
$$E_{AS(AR)} = P_D(\text{ave}) \cdot t_{av}$$

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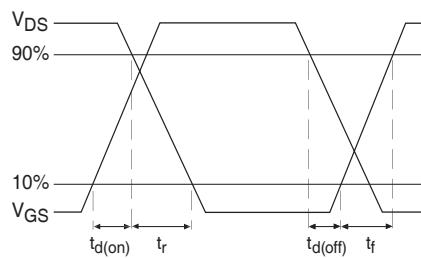
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**IR** Rectifier



**Fig 17.** Peak Diode Recovery  $dv/dt$  Test Circuit for N-Channel HEXFET® Power MOSFETs

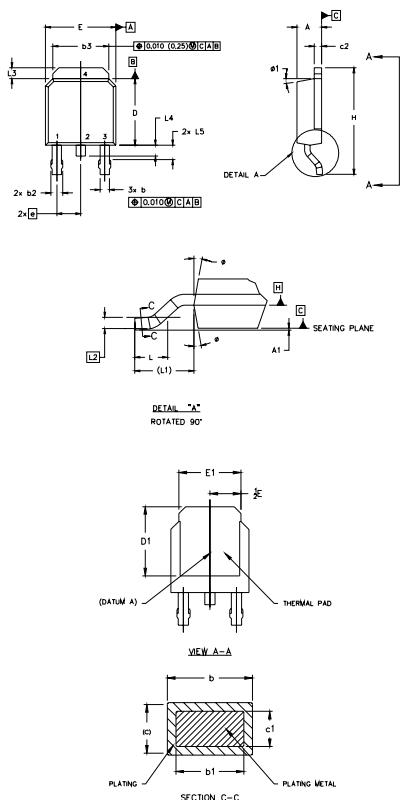


**Fig 18a.** Switching Time Test Circuit



**Fig 18b.** Switching Time Waveforms

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**IR** Rectifier  
**D-Pak (TO-252AA) Package Outline**



**NOTES:**

- 1.0 DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.
- 2.0 DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS].
- 3.0 LEAD DIMENSION UNCONTROLLED IN LS.
- 4.0 DIMENSION D1 AND E1 ESTABLISHED A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.0 SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 [0.127] AND .010 [0.2540] FROM THE LEAD TIP.
- 6.0 DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTER MOST EXTREMES OF THE PLASTIC BODY.
- 7.0 OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

SYMBOL	DIMENSIONS		NOTES
	MILLIMETERS	INCHES	
	MM. MAX.	IN. MAX.	
A	2.18	.239	.086 .094
A1		.13	.005
b	.64	.089	.025 .035
b1	.64	.079	.025 .035
b2	.76	.114	.030 .045
b3	4.95	5.46	.195 .215
c	.46	.61	.018 .024
c1	.41	.56	.016 .022
c2	.046	.089	.018 .035
D	5.97	6.22	.235 .245
D1	5.21	-	.205 -
E	6.35	6.73	.250 .265
E1	4.32	-	.170 -
e		.29	.090 BSC
H	9.40	10.41	.370 .410
L	1.40	1.78	.055 .070
L1		2.74 REF.	.108 REF.
L2		.0551 BSC	.020 BSC
L3	.089	1.27	.035 .090
L4		1.02	.040
L5	1.14	1.52	.045 .060
o	0"	10"	0" 10"
ø1	0"	15"	0" 15"

LEAD ASSIGNMENTS

HEXFET

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

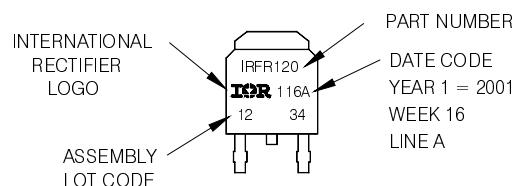
IGBTs, CoPACK

- 1.- GATE
- 2.- COLLECTOR
- 3.- Emitter
- 4.- COLLECTOR

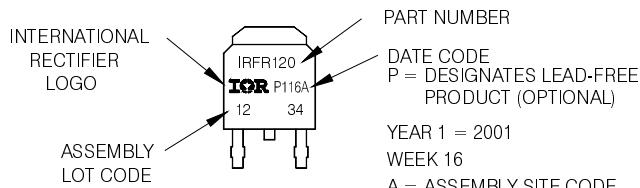
## D-Pak (TO-252AA) Part Marking Information

EXAMPLE: THIS IS AN IRFR120  
 WITH ASSEMBLY  
 LOT CODE 1234  
 ASSEMBLED ON WW 16, 2001  
 IN THE ASSEMBLY LINE 'A'

Note: 'P' in assembly line position  
 indicates 'Lead-Free'



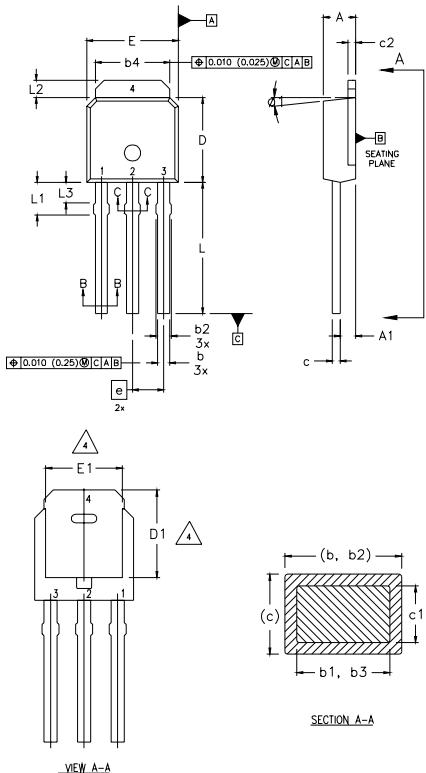
OR



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## I-Pak (TO-251AA) Package Outline



### NOTES:

- 1 DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994.
- 2 DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3 DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 4 THERMAL PAD CONTOUR OPTION WITHIN DIMENSION b4, L2, E1 & D1.
- 5 LEAD DIMENSION UNCONTROLLED IN L3.
- 6 DIMENSION b1, b3 APPLY TO BASE METAL ONLY.
- 7 OUTLINE CONFORMS TO JEDEC OUTLINE TO-251AA.
- 8 CONTROLLING DIMENSION : INCHES.

### LEAD ASSIGNMENTS

SYMBOL	DIMENSIONS				NOTES	
	MILLIMETERS		INCHES			
	MIN.	MAX.	MIN.	MAX.		
A	2.18	2.39	0.086	.094		
A1	0.89	1.14	0.035	0.045		
b	0.64	0.89	0.025	0.035		
b1	0.64	0.79	0.025	0.031		
b2	0.76	1.14	0.030	0.045		
b3	0.76	1.04	0.030	0.041		
b4	5.00	5.46	0.195	0.215		
c	0.46	0.61	0.018	0.024		
c1	0.41	0.56	0.016	0.022		
c2	.046	0.86	0.018	0.035		
D	5.97	6.22	0.235	0.245	3, 4	
D1	5.21	—	0.205	—	4	
E	6.35	6.73	0.250	0.265	3, 4	
E1	4.32	—	0.170	—	4	
	2.29		0.090 BSC			
L	8.89	9.60	0.350	0.380		
L1	1.91	2.29	0.075	0.090		
L2	0.89	1.27	0.035	0.050		
L3	1.14	1.52	0.045	0.060		
ø1	0"	15'	0"	15'	5	

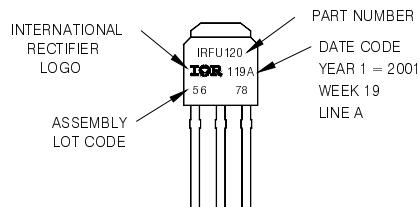
### HEXFET

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

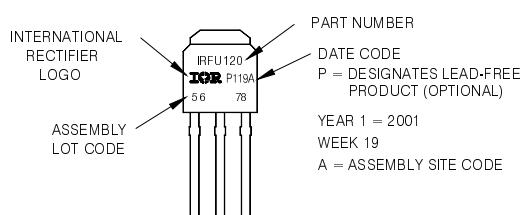
## I-Pak (TO-251AA) Part Marking Information

EXAMPLE: THIS IS AN IRFU120  
WITH ASSEMBLY  
LOT CODE 5678  
ASSEMBLED ON WW 19, 2001  
IN THE ASSEMBLY LINE 'A'

Note: 'P' in assembly line position  
indicates Lead-Free™



OR

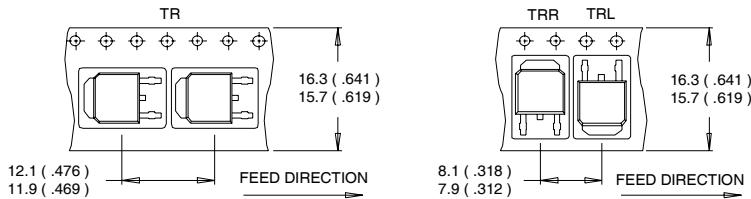


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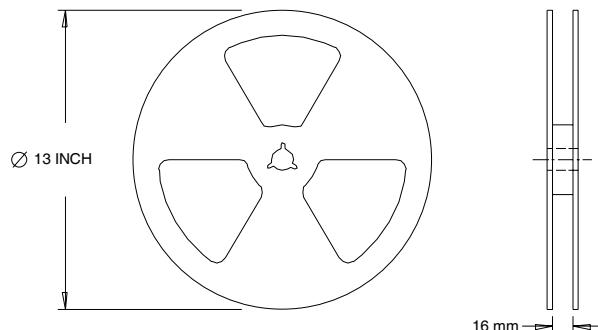
## D-Pak (TO-252AA) Tape & Reel Information

Dimensions are shown in millimeters (inches)



NOTES :

1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS ( INCHES ).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES :

1. OUTLINE CONFORMS TO EIA-481.

**Notes:**

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11).
- ② Limited by  $T_{Jmax}$ , starting  $T_J = 25^\circ\text{C}$ ,  $L = 0.16\text{mH}$   $R_G = 25\Omega$ ,  $I_{AS} = 38\text{A}$ ,  $V_{GS} = 10\text{V}$ . Part not recommended for use above this value.
- ③ Pulse width  $\leq 1.0\text{ms}$ ; duty cycle  $\leq 2\%$ .
- ④  $C_{oss}$  eff. is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- ⑤ Limited by  $T_{Jmax}$ , see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- ⑥ This value determined from sample failure population. 100% tested to this value in production.
- ⑦ When mounted on 1" square PCB (FR-4 or G-10 Material).
- ⑧  $R_\theta$  is measured at  $T_J$  approximately  $90^\circ\text{C}$ .

Data and specifications subject to change without notice.  
This product has been designed for the Automotive [Q101] market.  
Qualification Standards can be found on IR's Web site.

International  
**IR** Rectifier

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